



ALPHA & OMEGA
SEMICONDUCTOR, LTD

AO9926B

Dual N-Channel Enhancement Mode Field Effect Transistor

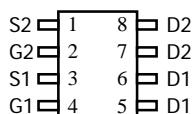


General Description

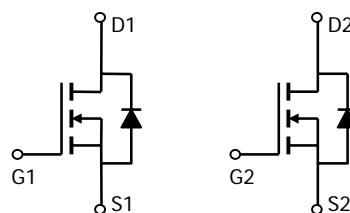
The AO9926B uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 1.8V while retaining a 12V $V_{GS(MAX)}$ rating. This device is suitable for use as a uni-directional or bi-directional load switch. Standard Product AO9926B is Pb-free (meets ROHS & Sony 259 specifications). AO9926BL is a Green Product ordering option. AO9926B and AO9926BL are electrically identical.

Features

V_{DS} (V) = 20V
 I_D = 7.6 A (V_{GS} = 10V)
 $R_{DS(ON)} < 23m\Omega$ (V_{GS} = 10V)
 $R_{DS(ON)} < 26m\Omega$ (V_{GS} = 4.5V)
 $R_{DS(ON)} < 34m\Omega$ (V_{GS} = 2.5V)
 $R_{DS(ON)} < 52m\Omega$ (V_{GS} = 1.8V)



SOIC-8



Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

Parameter	Symbol	Maximum	Units
Drain-Source Voltage	V_{DS}	20	V
Gate-Source Voltage	V_{GS}	± 12	V
Continuous Drain Current ^A	I_D	7.6	A
$T_A=70^\circ C$		6.1	
Pulsed Drain Current ^B	I_{DM}	30	
Power Dissipation ^A	P_D	2	W
$T_A=70^\circ C$		1.28	
Junction and Storage Temperature Range	T_J, T_{STG}	-55 to 150	°C

Thermal Characteristics

Parameter	Symbol	Typ	Max	Units
Maximum Junction-to-Ambient ^A	R_{0JA}	48	62.5	°C/W
Maximum Junction-to-Ambient ^A		74	110	°C/W
Maximum Junction-to-Lead ^C	R_{0JL}	35	50	°C/W

Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
STATIC PARAMETERS						
BV_{DSS}	Drain-Source Breakdown Voltage	$I_D=250\mu\text{A}, V_{GS}=0\text{V}$	20			V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=16\text{V}, V_{GS}=0\text{V}$	$T_J=55^\circ\text{C}$	1	5	μA
I_{GSS}	Gate-Body leakage current	$V_{DS}=0\text{V}, V_{GS}=\pm 10\text{V}$			100	nA
BV_{GSO}	Gate-Source Breakdown Voltage	$V_{DS}=0\text{V}, I_G=\pm 250\mu\text{A}$	± 12			V
$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	0.5	0.8	1	V
$I_{\text{D(ON)}}$	On state drain current	$V_{GS}=4.5\text{V}, V_{DS}=5\text{V}$	30			A
$R_{\text{DS(ON)}}$	Static Drain-Source On-Resistance	$V_{GS}=10\text{V}, I_D=7.6\text{A}$		18	23	$\text{m}\Omega$
		$T_J=125^\circ\text{C}$		25		
		$V_{GS}=4.5\text{V}, I_D=7\text{A}$		21	26	$\text{m}\Omega$
		$V_{GS}=2.5\text{V}, I_D=6\text{A}$		27	34	$\text{m}\Omega$
g_{FS}	Forward Transconductance	$V_{DS}=5\text{V}, I_D=7.6\text{A}$		38	52	$\text{m}\Omega$
		$V_{DS}=5\text{V}, I_D=7.6\text{A}$		24		S
		$I_S=1\text{A}, V_{GS}=0\text{V}$		0.7	1	V
		I_S Maximum Body-Diode Continuous Current			3.5	A
DYNAMIC PARAMETERS						
C_{iss}	Input Capacitance	$V_{GS}=0\text{V}, V_{DS}=10\text{V}, f=1\text{MHz}$		630		pF
C_{oss}	Output Capacitance			164		pF
C_{rss}	Reverse Transfer Capacitance			137		pF
R_g	Gate resistance	$V_{GS}=0\text{V}, V_{DS}=0\text{V}, f=1\text{MHz}$		1.5		Ω
SWITCHING PARAMETERS						
Q_g	Total Gate Charge	$V_{GS}=4.5\text{V}, V_{DS}=10\text{V}, I_D=7.6\text{A}$		8.8		nC
Q_{gs}	Gate Source Charge			1		nC
Q_{gd}	Gate Drain Charge			3.7		nC
$t_{\text{D(on)}}$	Turn-On Delay Time	$V_{GS}=5\text{V}, V_{DS}=10\text{V}, R_L=1.3\Omega, R_{\text{GEN}}=3\Omega$		5.5		ns
t_r	Turn-On Rise Time			14		ns
$t_{\text{D(off)}}$	Turn-Off Delay Time			29		ns
t_f	Turn-Off Fall Time			10.2		ns
t_{rr}	Body Diode Reverse Recovery Time	$I_F=7.6\text{A}, dI/dt=100\text{A}/\mu\text{s}$		15.2		ns
Q_{rr}	Body Diode Reverse Recovery Charge	$I_F=7.6\text{A}, dI/dt=100\text{A}/\mu\text{s}$		6.3		nC

A: The value of $R_{\theta JA}$ is measured with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The value in any given application depends on the user's specific board design. The current and power rating is based on the $\leq 10\text{s}$ thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to lead $R_{\theta JL}$ and lead to ambient.

D. The static characteristics in Figures 1 to 6, 12, 14 are obtained using 80 μs pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The SOA curve provides a single pulse rating.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

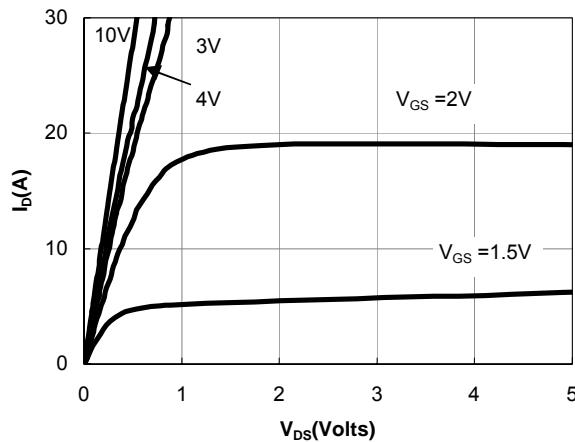


Figure 1: On-Regions Characteristics

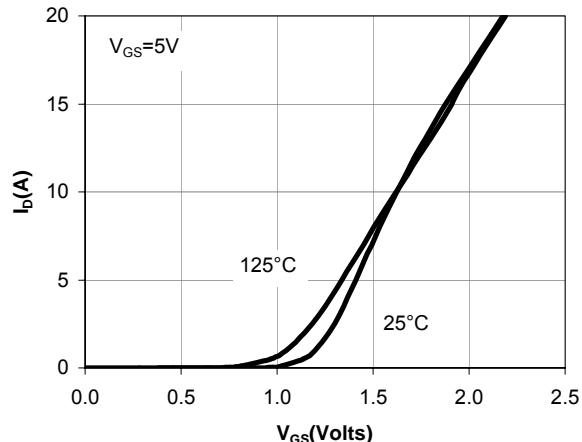


Figure 2: Transfer Characteristics

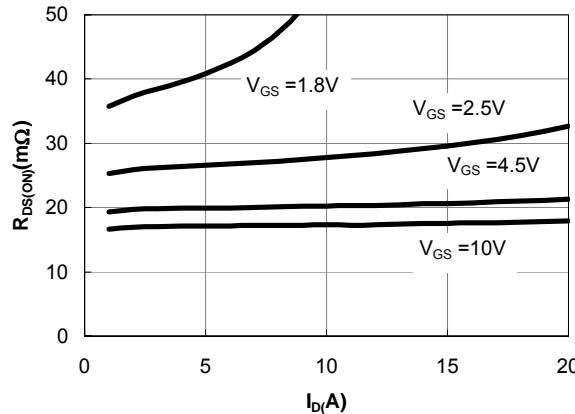


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

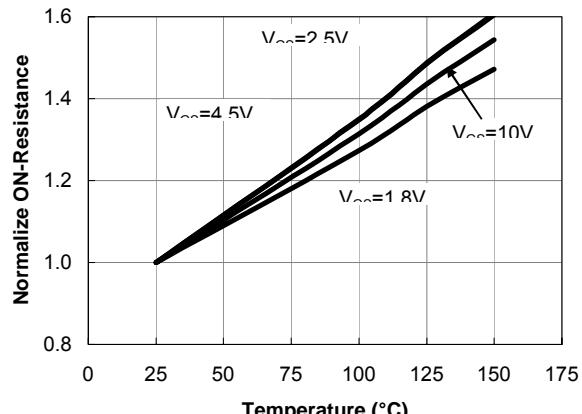


Figure 4: On-Resistance vs. Junction Temperature

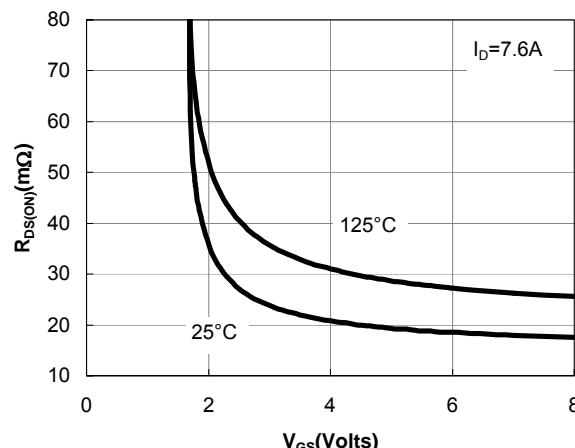


Figure 5: On-Resistance vs. Gate-Source Voltage

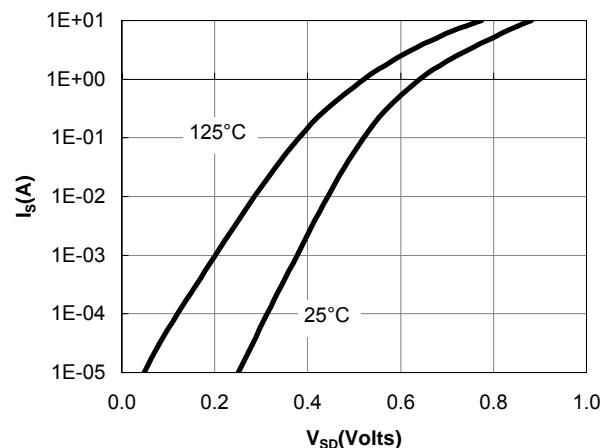


Figure 6: Body-Diode Characteristics

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